

Notice of References Cited	Application/Control No. 09/740,790	Applicant(s)/Patent Under Reexamination YAMAJI, HIROTAKE	
	Examiner Daniel A. Nolan	Art Unit 2654	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-5,774,856 A	06-1998	Haber et al.	704/201
X	B	US-6,240,185	05-2001	Van Wie et al.	380/232
X	C	US-6,243,330 B1	06-2001	Oshima, Mitsuaki	380/228
X	D	US-6,263,313 B1	07-2001	Milsted et al.	704/504
X	E	US-6,253,293 B1	06-2001	Rao et al.	704/500
X	F	US-5,303,326 A	04-1994	Dean et al.	704/201
X	G	US-2001/0038578 A1	11-2001	Oshima, Mitsuaki	369/13
X	H	US-6,226,618 B1	05-2001	Downs et al.	380/279
X	I	US-5,511,000 A	04-1996	Kaloi et al.	704/201
	J	US-5,987,519	11-1999	Peifer et al.	709/230
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
X	N	JP 09-265731	10-1997	Japan	Ozawa et al	G11B 20/10
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.